

**Main Product Characteristics:**

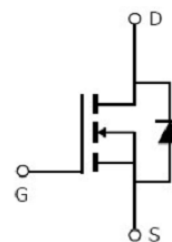
$V_{DSS}$	40V
$R_{DS(on)}$	2.4m $\Omega$ (typ.)
$I_D$	200A <sup>①</sup>



TO-220  
SSFT4003



TO-263  
SSFT4003A



Schematic diagram

**Features and Benefits:**

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 175°C operating temperature


**Description:**

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

**Absolute max Rating:**

Symbol	Parameter	Max.	Units
$I_D @ TC = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	200 <sup>①</sup>	A
$I_D @ TC = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	135 <sup>①</sup>	
$I_{DM}$	Pulsed Drain Current <sup>②</sup>	750	
$P_D @ TC = 25^\circ C$	Power Dissipation <sup>③</sup>	220	W
	Linear Derating Factor	1.5	W/ $^\circ C$
$V_{DS}$	Drain-Source Voltage	40	V
$V_{GS}$	Gate-to-Source Voltage	$\pm 24$	V
$E_{AS}$	Single Pulse Avalanche Energy @ L=0.3mH	912	mJ
$I_{AS}$	Avalanche Current @ L=0.3mH	78	A
$T_J T_{STG}$	Operating Junction and Storage Temperature Range	-55 to +175	$^\circ C$


## Thermal Resistance

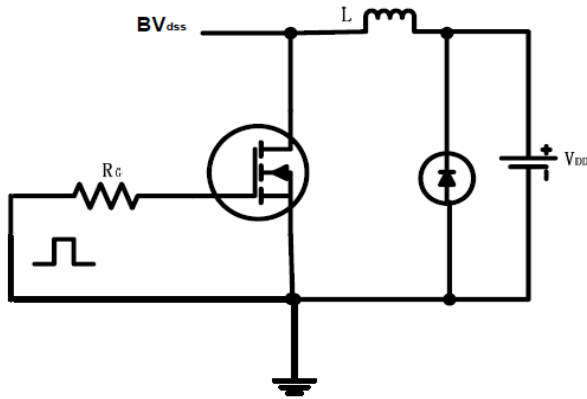
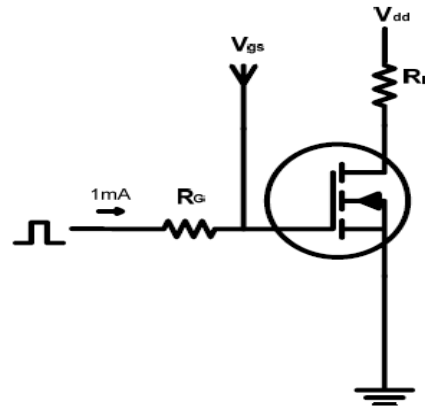
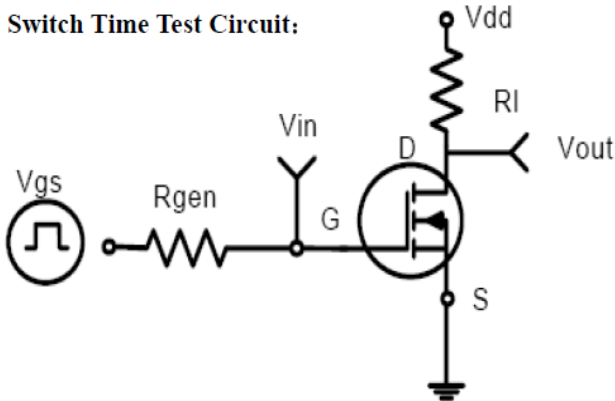
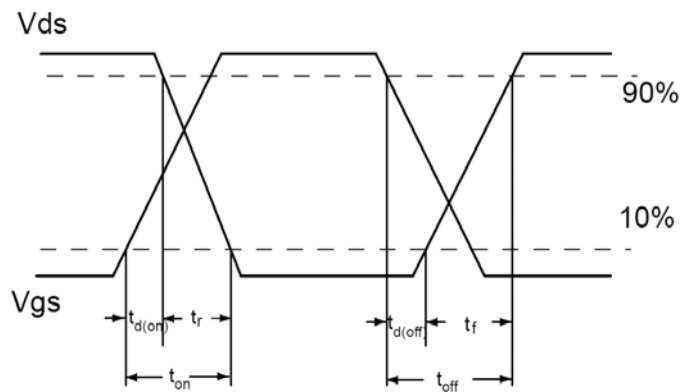
Symbol	Characterizes	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-case <sup>③</sup>	—	0.62	°C/W
$R_{\theta JA}$	Junction-to-ambient ( $t \leq 10s$ ) <sup>④</sup>	—	60	°C/W
	Junction-to-Ambient (PCB mounted, steady-state) <sup>④</sup>	—	40	°C/W

## Electrical Characterizes @ $T_A=25^\circ\text{C}$ unless otherwise specified

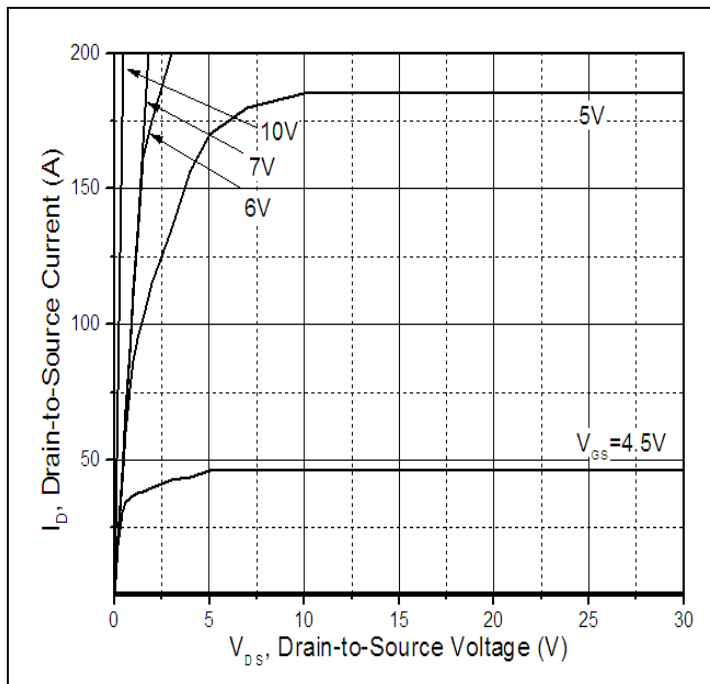
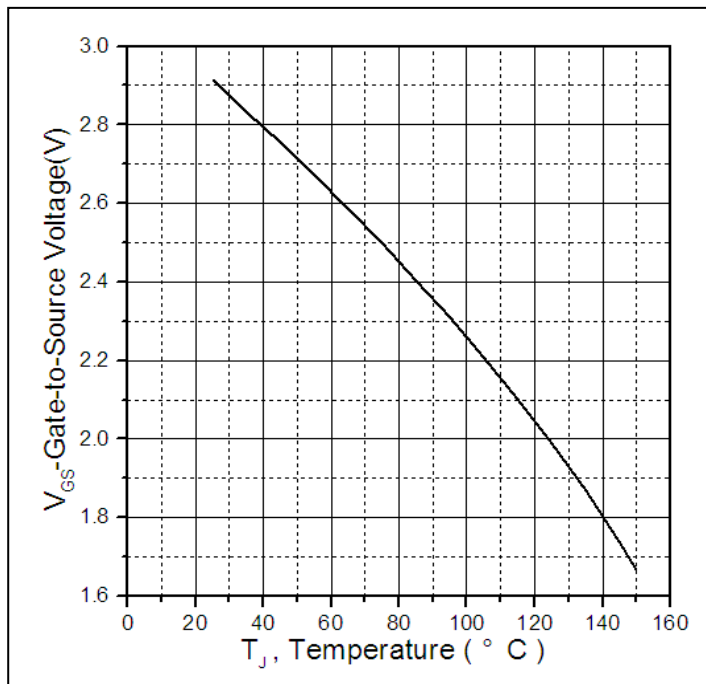
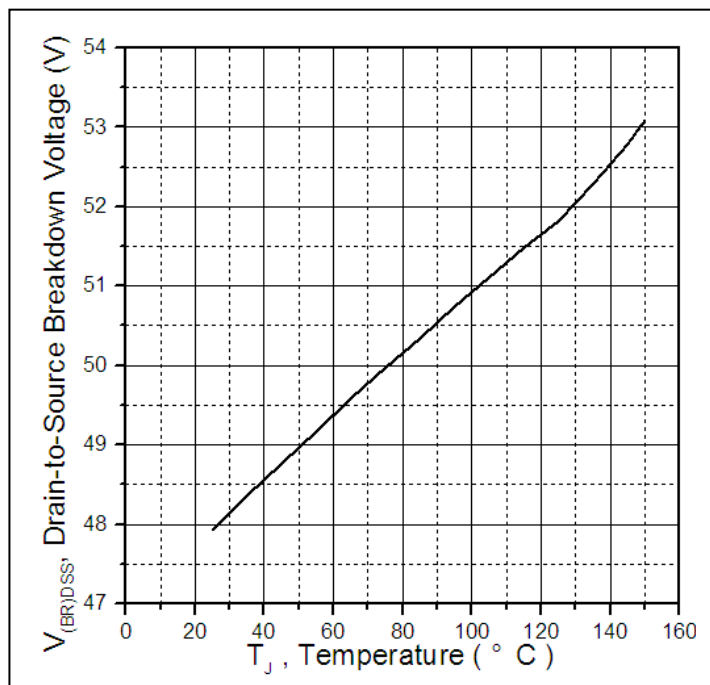
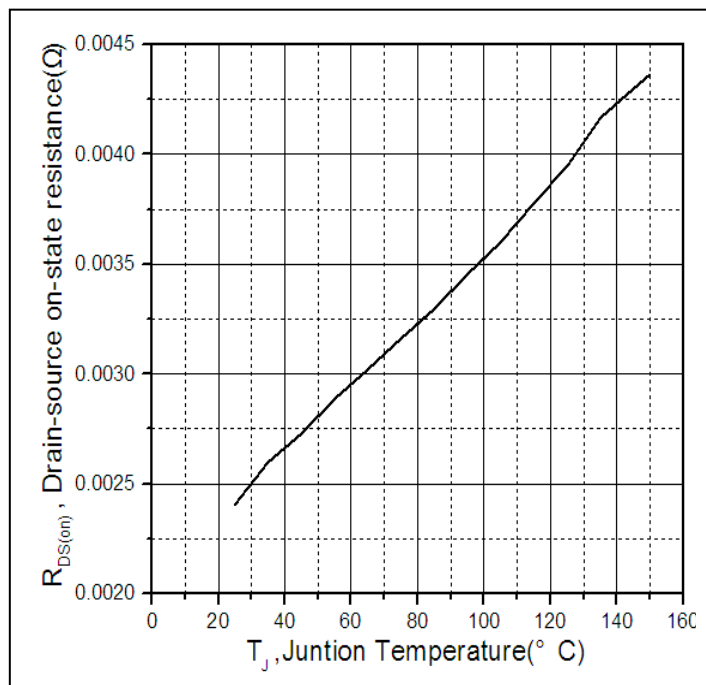
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source breakdown voltage	40	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	2.4	3.5	m $\Omega$	$V_{GS}=10V, I_D = 30A$ $T_J = 125^\circ\text{C}$
		—	4.1	—		
$V_{GS(th)}$	Gate threshold voltage	2	—	4	V	$V_{DS} = V_{GS}, I_D = 250\mu A$ $T_J = 125^\circ\text{C}$
		—	2.0	—		
$I_{DSS}$	Drain-to-Source leakage current	—	—	1	$\mu A$	$V_{DS} = 40V, V_{GS} = 0V$ $T_J = 125^\circ\text{C}$
		—	—	50		
$I_{GSS}$	Gate-to-Source forward leakage	—	—	100	nA	$V_{GS} = 24V$ $V_{GS} = -24V$
		—	—	-100		
$Q_g$	Total gate charge	—	104	—	nC	$I_D = 75A,$ $V_{DS} 32V,$ $V_{GS} = 10V$
$Q_{gs}$	Gate-to-Source charge	—	16	—		
$Q_{gd}$	Gate-to-Drain("Miller") charge	—	40	—		
$t_{d(on)}$	Turn-on delay time	—	21.4	—	ns	$V_{GS}=10V, V_{DS} = 20V,$ $R_L=0.26\Omega,$ $R_{GEN}=3.0\Omega,$ $I_D = 75A$
$t_r$	Rise time	—	57.8	—		
$t_{d(off)}$	Turn-Off delay time	—	48.7	—		
$t_f$	Fall time	—	19.9	—		
$C_{iss}$	Input capacitance	—	7615	—	pF	$V_{GS} = 0V,$ $V_{DS} = 25V,$ $f = 1\text{MHz}$
$C_{oss}$	Output capacitance	—	959	—		
$C_{riss}$	Reverse transfer capacitance	—	342	—		

## Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	200 <sup>①</sup>	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode)	—	—	750	A	
$V_{SD}$	Diode Forward Voltage	—	0.86	1.3	V	$I_S=30A, V_{GS}=0V$
$t_{rr}$	Reverse Recovery Time	—	29.6	—	ns	$T_J = 25^\circ\text{C}, I_F = 50A, di/dt =$
$Q_{rr}$	Reverse Recovery Charge	—	22.2	—	nC	100A/ $\mu s$

**Test circuits and Waveforms**
**EAS test circuits:**

**Gate charge test circuit:**

**Switch Time Test Circuit:**

**Switch Waveforms:**

**Notes:**

- ① Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ② Repetitive rating; pulse width limited by max junction temperature.
- ③ The power dissipation PD is based on max junction temperature, using junction-to-case thermal resistance.
- ④ The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$

**Typical electrical and thermal characteristics**

**Figure 1: Typical Output Characteristics**

**Figure 2. Gate to source cut-off voltage**

**Figure 3. Drain-to-Source Breakdown Voltage Vs. Case Temperature**

**Figure 4: Normalized On-Resistance Vs. Case Temperature**

Typical electrical and thermal characteristics

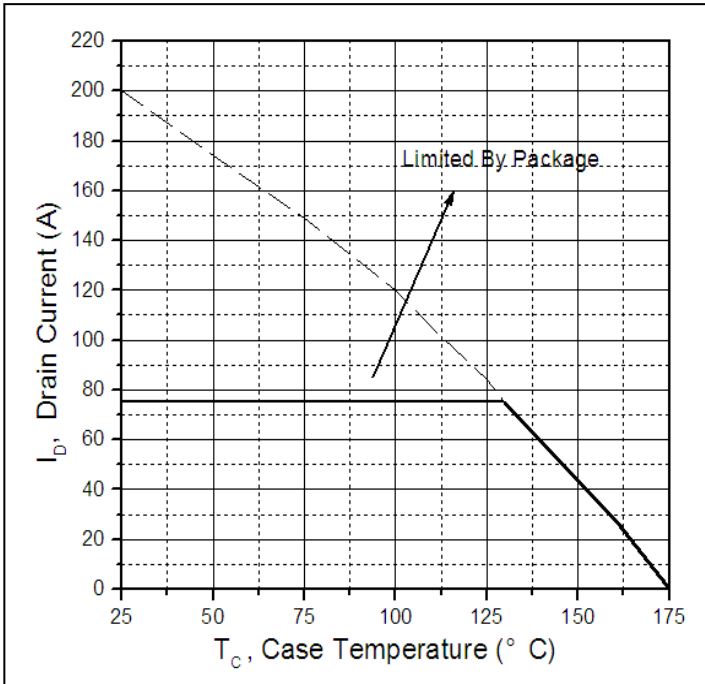


Figure 5. Maximum Drain Current Vs. Case Temperature

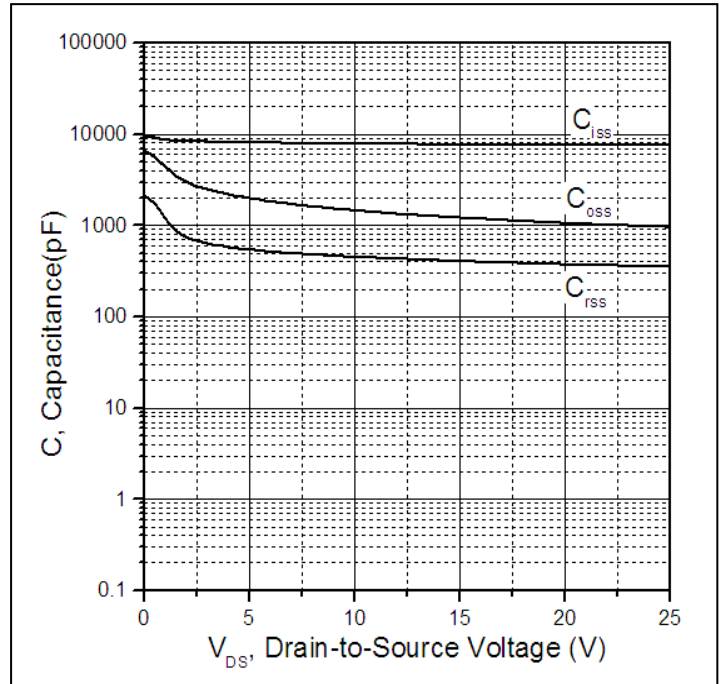


Figure 6. Typical Capacitance Vs. Drain-to-Source Voltage

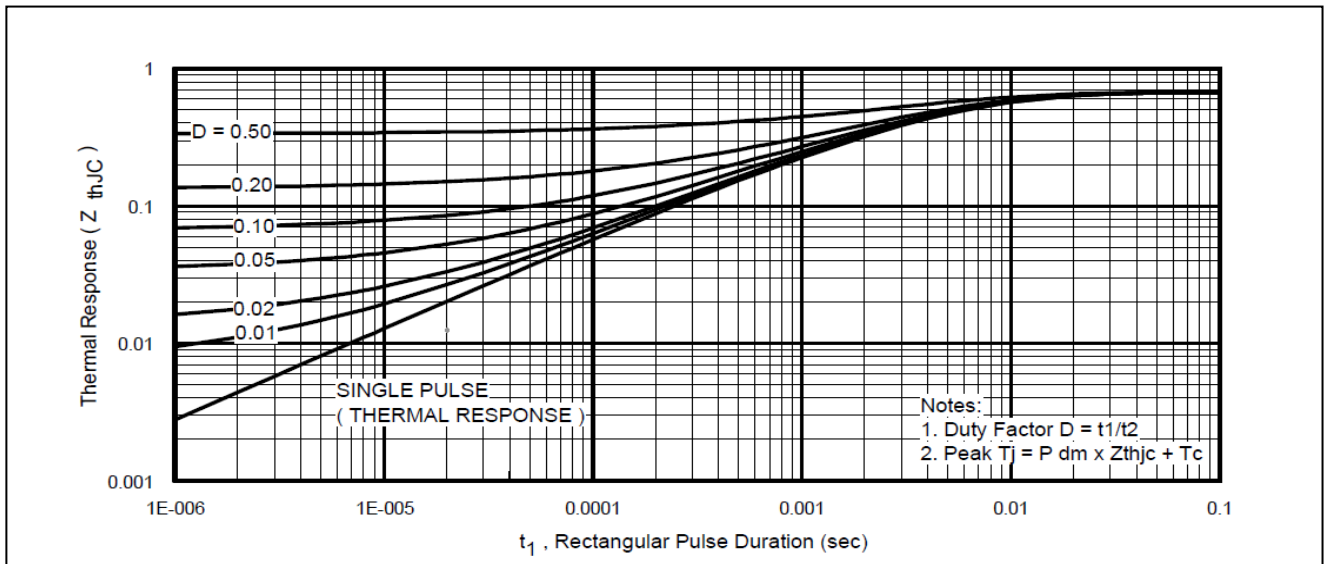
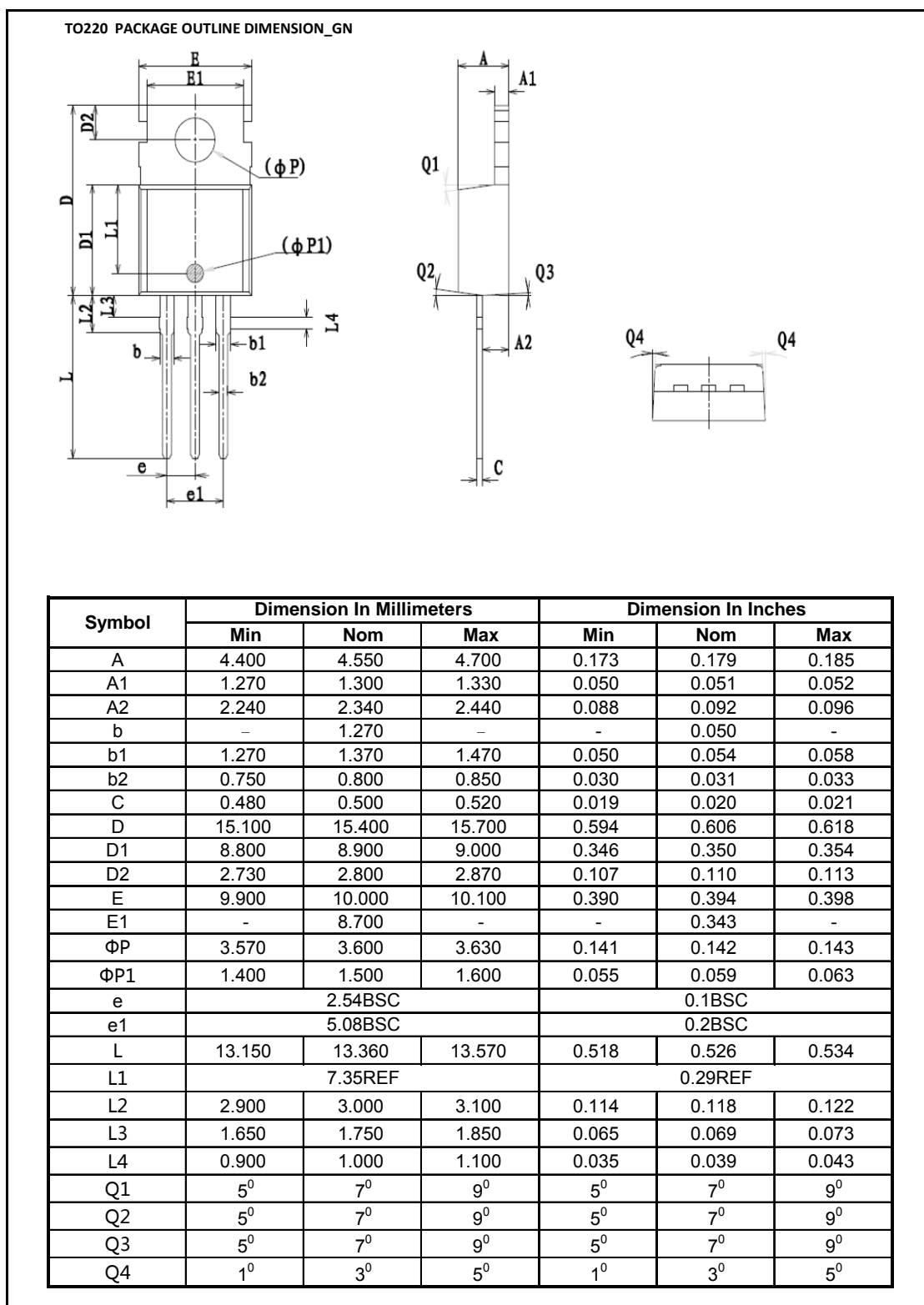
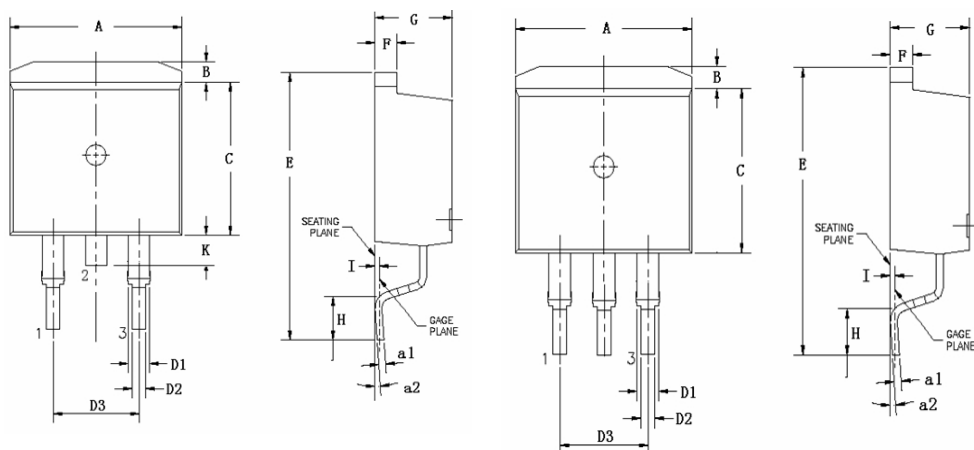


Figure 7. Maximum Effective Transient Thermal Impedance, Junction-to-Case

**Mechanical Data:**


**D2PAK PACKAGE OUTLINE DIMENSION**


Symbol	Dimension In Millimeters		Dimension In Inches	
	Min	Max	Min	Max
A	9.660	10.280	0.380	0.405
B	1.020	1.320	0.040	0.052
C	8.590	9.400	0.338	0.370
D1	1.140	1.400	0.045	0.055
D2	0.700	0.950	0.028	0.037
D3	5.080 (TYP)		0.200 (TYP)	
E	15.090	15.390	0.594	0.606
F	1.150	1.400	0.045	0.055
G	4.300	4.700	0.169	0.185
H	2.290	2.790	0.090	0.110
I	0.250 (TYP)		0.010 (TYP)	
K	1.300	1.600	0.051	0.063
a1	0.450	0.650	0.018	0.026
a2	0°	8°	1°	8°

**Ordering and Marking Information**
**Device Marking: SSFT4003 & SSFT4003A**
**Package (Available)**
**TO220/TO263**
**Operating Temperature Range**
**C : -55 to 175 °C**
**Devices per Unit**

Package Type	Units/Tube	Tubes/Inner Box	Units/Inner Box	Inner Boxes/ Carton Box	Units/ Carton Box
TO220	50	20	1000	6	6000
D2PAK	50	20	1000	6	6000

**Reliability Test Program**

Test Item	Conditions	Duration	Sample Size
High Temperature Reverse Bias(HTRB)	T <sub>j</sub> =125°C to 175°C @ 80% of Max V <sub>DSS</sub> /V <sub>CES</sub> /V <sub>R</sub>	168 hours 500 hours 1000 hours	3 lots x 77 devices
High Temperature Gate Bias(HTGB)	T <sub>j</sub> =150°C or 175°C @ 100% of Max V <sub>GSS</sub>	168 hours 500 hours 1000 hours	3 lots x 77 devices



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